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July 28, 2003	1745						

Application Number 10/628,681

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EXAMINER	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION			
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EXAMINER: Initial if citation is considered, whether or not citati If not conformance and not considered. Include copy with next con	on is in conformance with MPEP § 609: Draw Line through citation numbers of applicant.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1

Complete if Known					
Application Number	10/628681-Conf. #4491				
Filing Date	July 28, 2003				
First Named Inventor	Gilbert N. RILEY				
Art Unit	1745				
Examiner Name	Not Yet Assigned				
Attorney Docket Number	0112903.00128US2				

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				Application Number	10/628681-Conf. #4491	
18	VFORMATION	N DI	SCLOSURE	Filing Date	July 28, 2003	
S	TATEMENT	BY A	APPLICANT	First Named Inventor	Gilbert N. RILEY	
				Art Unit	1745	
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				Application Number	10/628681-Conf. #4491	
IR	IFORMATIC	N DI	SCLOSURE	Filing Date	July 28, 2003	
S	TATEMENT	BY	APPLICANT	First Named Inventor	Gilbert N. RILEY	
				Art Unit	1745	
	(Use as many	sheets as	necessary)	Examiner Name	Not Yet Assigned	
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l s	TATEMENT !	3Y /	APPLICANT	First Named Inventor	Gilbert N. RILEY	
				Art Unit	1745	
	(Use as many sh	eets as	s necessary)	Examiner Name	Not Yet Assigned	
Sheet	4	of	5	Attorney Docket Number	0112903.00128US2	

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Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
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STA	TEMEN'	T BY	APPLICANT	First Named Inventor	Gilbert N. RILEY	
			-	Art Unit	1745	
(Use as many sheets as necessary)				Examiner Name	Not Yet Assigned	
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^{*}EXAMINER: thitial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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